

# AP6985GN2-HF

**Halogen-Free Product**

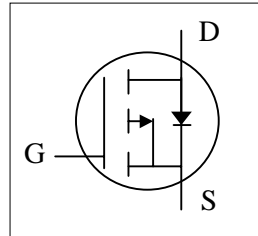


**Advanced Power  
Electronics Corp.**

*P-CHANNEL ENHANCEMENT MODE*

*POWER MOSFET*

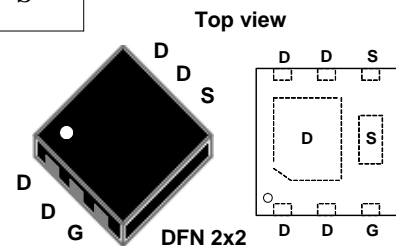
- ▼ Capable of 1.8V Gate Drive
- ▼ Small Size & Lower Profile
- ▼ Halogen Free & RoHS Compliant Product



$BV_{DSS}$	-20V
$R_{DS(ON)}$	26m $\Omega$
$I_D$	-8A

## Description

AP6985 series are from Advanced Power innovated design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.



## Absolute Maximum Ratings @ $T_j=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	-20	V
$V_{GS}$	Gate-Source Voltage	$\pm 8$	V
$I_D @ T_A=25^\circ\text{C}$	Drain Current <sup>3</sup> @ $V_{GS}=4.5\text{V}$	-8	A
$I_D @ T_A=70^\circ\text{C}$	Drain Current <sup>3</sup> @ $V_{GS}=4.5\text{V}$	-6.4	A
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	-30	A
$P_D @ T_A=25^\circ\text{C}$	Total Power Dissipation <sup>3</sup>	2.4	W
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
$T_J$	Operating Junction Temperature Range	-55 to 150	$^\circ\text{C}$

## Thermal Data

Symbol	Parameter	Value	Unit
$R_{thj-a}$	Maximum Thermal Resistance, Junction-ambient <sup>3</sup>	52	$^\circ\text{C}/\text{W}$



# AP6985GN2-HF

## Electrical Characteristics @T<sub>j</sub>=25°C (unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =-250uA	-20	-	-	V	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-7A	-	23	26	mΩ	
		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-4A	-	29	35	mΩ	
		V <sub>GS</sub> =-1.8V, I <sub>D</sub> =-2A	-	34	45	mΩ	
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250uA	-0.3	-	-1	V	
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-7A	-	21	-	S	
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =-16V, V <sub>GS</sub> =0V	-	-	-10	uA	
I <sub>GSS</sub>	Gate-Source Leakage	V <sub>GS</sub> =±8V, V <sub>DS</sub> =0V	-	-	±100	nA	
Q <sub>g</sub>	Total Gate Charge	I <sub>D</sub> =-7A	-	16	27	nC	
Q <sub>gs</sub>	Gate-Source Charge		V <sub>DS</sub> =-10V	-	3	-	nC
Q <sub>gd</sub>	Gate-Drain ("Miller") Charge		V <sub>GS</sub> =-4.5V	-	6	-	nC
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>DS</sub> =-10V	-	9	-	ns	
t <sub>r</sub>	Rise Time		I <sub>D</sub> =-1A	-	15	-	ns
t <sub>d(off)</sub>	Turn-off Delay Time	R <sub>G</sub> =3.3Ω	-	60	-	ns	
t <sub>f</sub>	Fall Time	V <sub>GS</sub> =-5V	-	32	-	ns	
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V	-	1655	2640	pF	
C <sub>oss</sub>	Output Capacitance		V <sub>DS</sub> =-10V	-	175	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		f=1.0MHz	-	150	-	pF
R <sub>g</sub>	Gate Resistance	f=1.0MHz	-	10	20	Ω	

## Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V <sub>SD</sub>	Forward On Voltage <sup>2</sup>	I <sub>S</sub> =-2A, V <sub>GS</sub> =0V	-	-	-1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>S</sub> =-7A, V <sub>GS</sub> =0V, dI/dt=100A/μs	-	27	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge		-	24	-	nC

### Notes:

1. Pulse width limited by Max. junction temperature.

2. Pulse test

3. Surface mounted on 1 in<sup>2</sup> 2oz copper pad of FR4 board, t ≤ 10s ; 165°C/W when mounted on min. copper pad.

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

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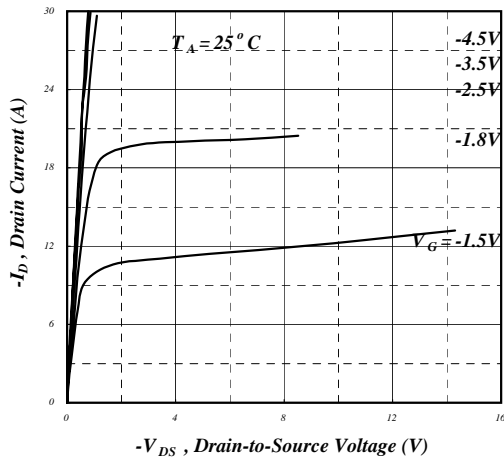


Fig 1. Typical Output Characteristics

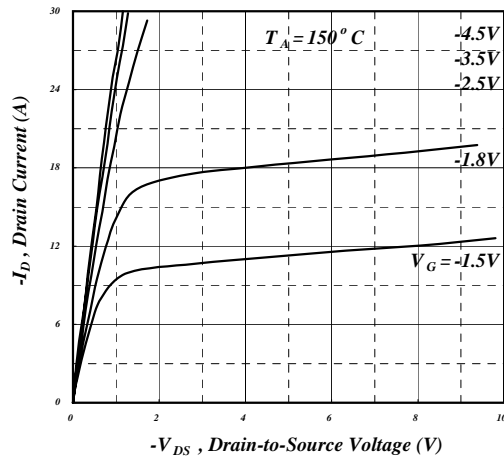


Fig 2. Typical Output Characteristics

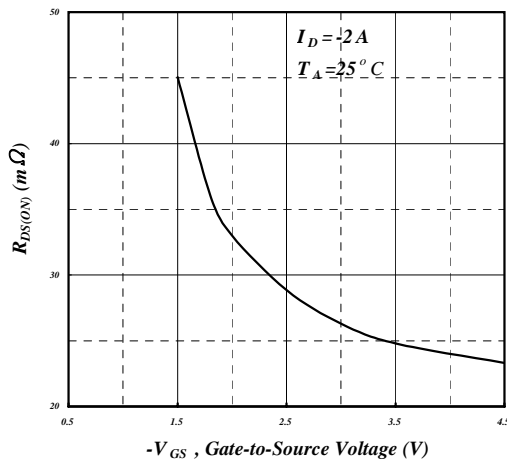


Fig 3. On-Resistance v.s. Gate Voltage

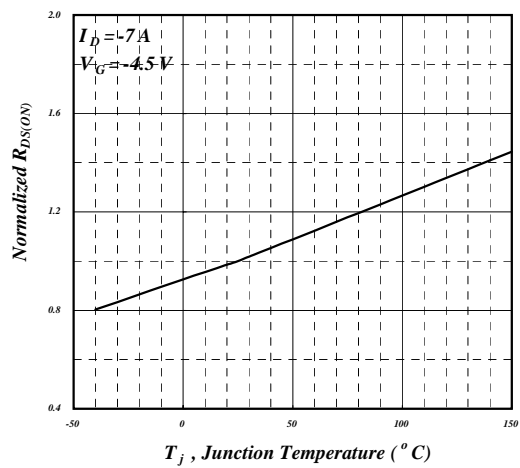


Fig 4. Normalized On-Resistance v.s. Junction Temperature

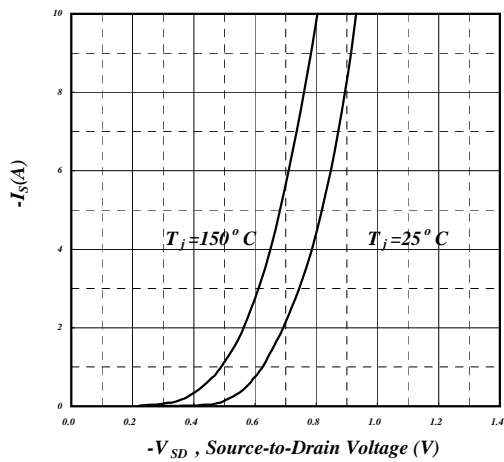


Fig 5. Forward Characteristic of Reverse Diode

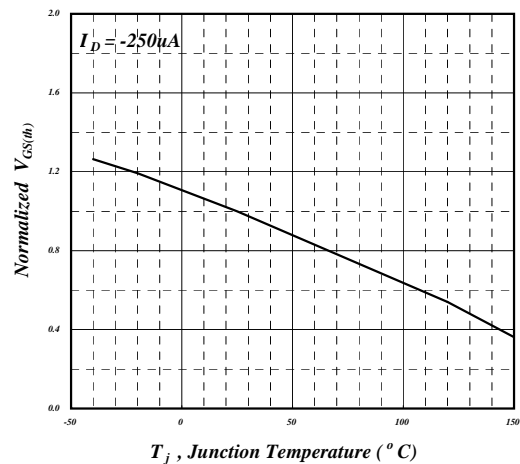


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

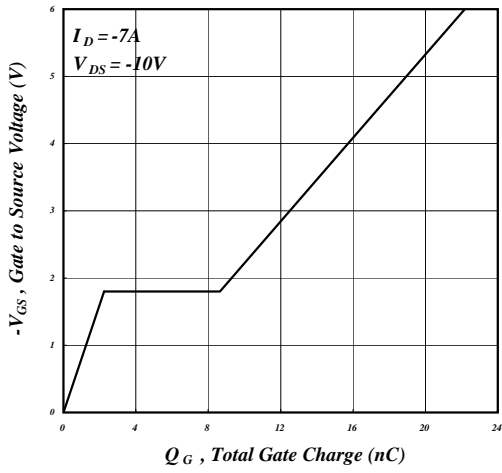


Fig 7. Gate Charge Characteristics

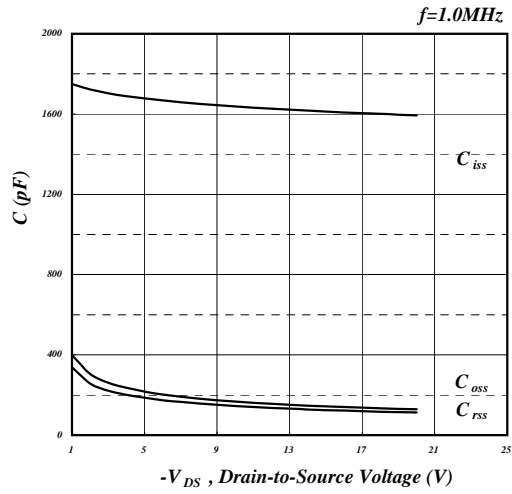


Fig 8. Typical Capacitance Characteristics

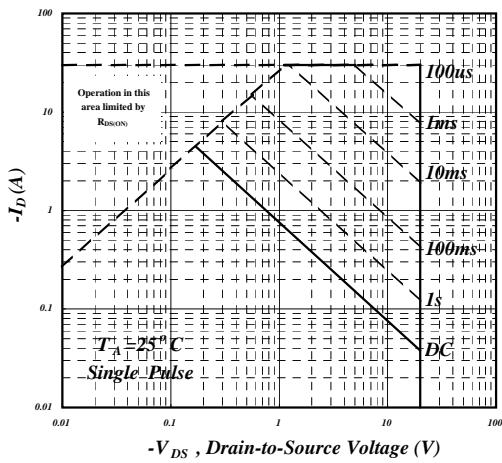


Fig 9. Maximum Safe Operating Area

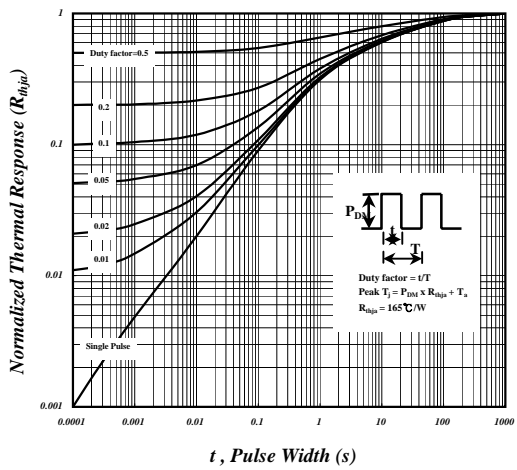


Fig 10. Effective Transient Thermal Impedance

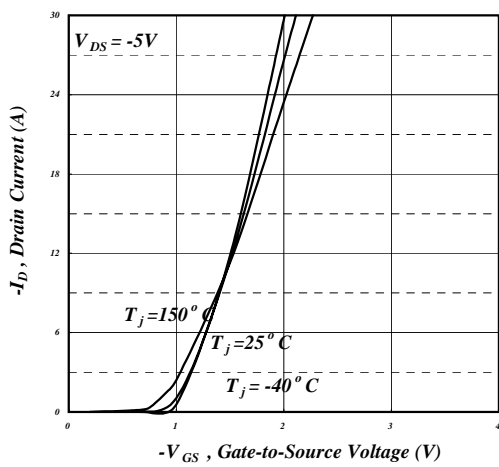


Fig 11. Transfer Characteristics

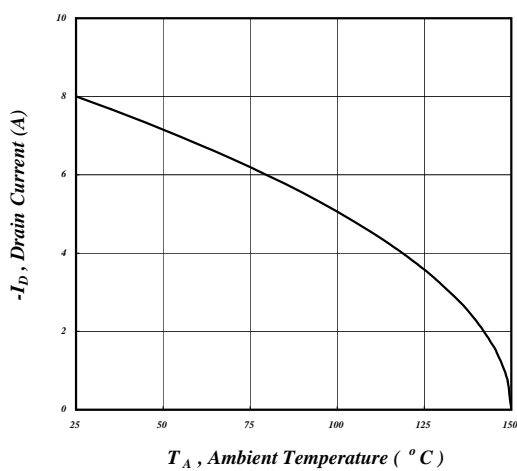
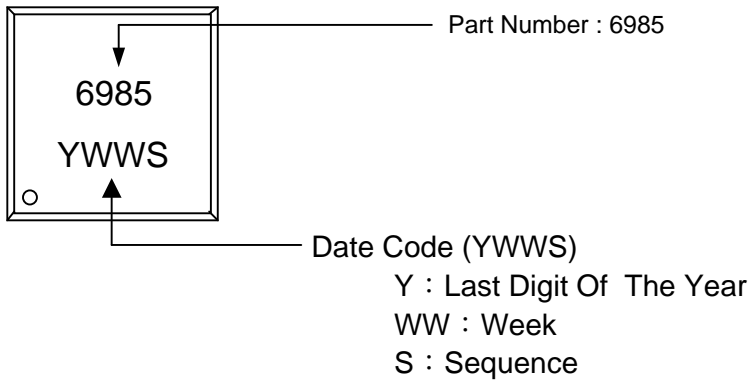


Fig 12. Drain Current v.s. Ambient Temperature



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